

**April 2013** 

# **FDD6N50/ FDU6N50**

# N-Channel UniFET<sup>TM</sup> MOSFET 500 V, 6 A, 900 m $\Omega$

#### **Features**

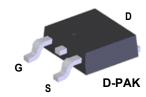
- Low Gate Charge (Typ.12.8 nC)
- Low C<sub>rss</sub> (Typ. 9 pF)
- 100% Avalanche Tested
- · Improved dv/dt Capability

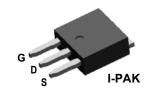
# **Applications**

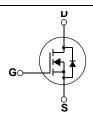
- LCD/LED/PDP TV
- · Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply

# **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor<sup>®</sup>'s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.







# **Absolute Maximum Ratings**

Symbol	Parameter		FDD6N50/ FDU6N50	Unit	
V <sub>DSS</sub>	Drain-Source Voltage		500	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		6 3.8	A A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		24	А
V <sub>GSS</sub>	Gate-Source voltage		±30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	270	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	6	А
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	8.9	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate above 25°C		89 0.71	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

# **Thermal Characteristics**

Symbol	Parameter	FDD6N50/ FDU6N50	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	1.4	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	83	C/VV	

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDD6N50	FDD6N50TM	D-PAK	380mm	16mm	2500
FDD6N50S	FDD6N50TM_WS	D-PAK	380mm	16mm	2500
FDU6N50	FDU6N50TU	I-PAK	-	-	70

# **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit
Off Charac	teristics			I.		I.
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $V_{GS} = 0V$ , $I_D = 250\mu A$		500			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C		0.5		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V V <sub>DS</sub> = 400V, T <sub>C</sub> = 125°C			1 10	μA μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30V, V <sub>DS</sub> = 0V	-		100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30V, V <sub>DS</sub> = 0V			-100	nA
On Charac	teristics				_	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 3A		0.76	0.9	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40V, I <sub>D</sub> = 3A		2.5		S
Dynamic C	: haracteristics	•				•
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V,		720	940	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0MHz	-	95	190	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			9	13.5	pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 250V, I <sub>D</sub> = 6A		6	20	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25\Omega$		55	120	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		1	25	60	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	ı	35	80	ns
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 400V, I <sub>D</sub> = 6A	ı	12.8	16.6	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = 10V	ı	3.7		nC
$Q_{gd}$	Gate-Drain Charge	(Note 4)		5.8		nC
Drain-Sour	ce Diode Characteristics and Maximur	n Ratings		I.		ı
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				6	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		-		24	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 6A			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>S</sub> = 6A	-	275		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt =100A/μs		1.7		μС

#### NOTES:

<sup>1.</sup> Repetitive Rating: Pulse width limited by maximum junction temperature

<sup>2.</sup> I<sub>AS</sub> = 6A, V<sub>DD</sub> = 50V, L=13.5mH, R<sub>G</sub> = 25 $\Omega$ , Starting T<sub>J</sub> = 25 $^{\circ}$ C

<sup>3.</sup>  $I_{SD} \le 6 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J$  =  $25^{\circ}C$ 

<sup>4.</sup> Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

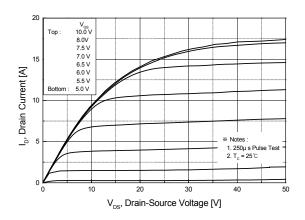


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

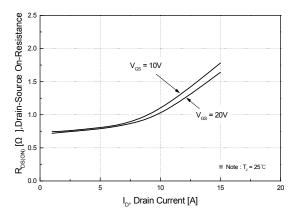


Figure 5. Capacitance Characteristics

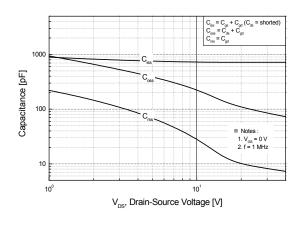


Figure 2. Transfer Characteristics

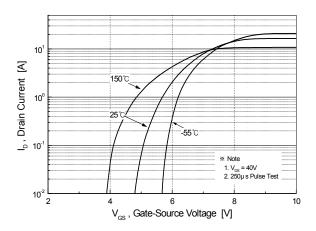


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

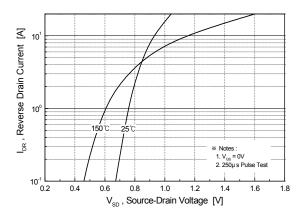
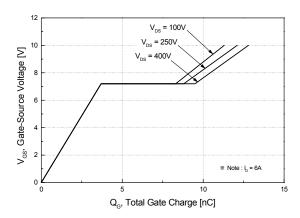


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

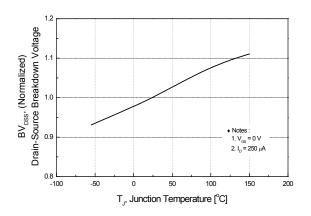


Figure 8. On-Resistance Variation vs. Temperature

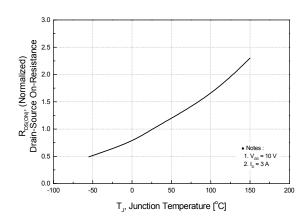


Figure 9. Maximum Safe Operating Area

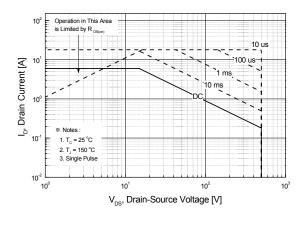


Figure 10. Maximum Drain Current vs. Case Temperature

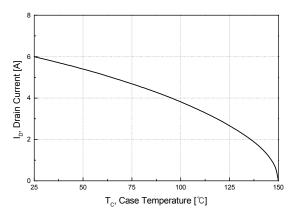
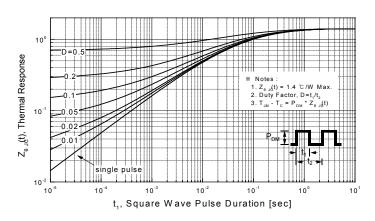
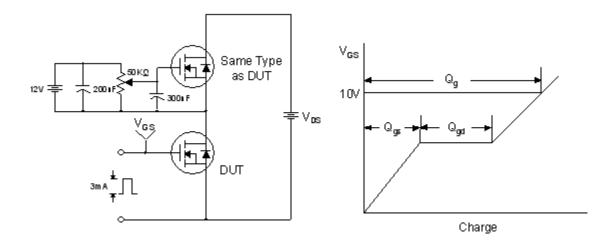


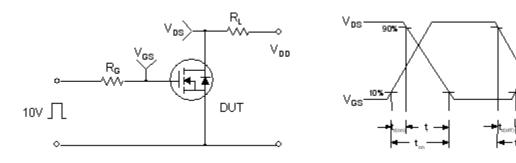
Figure 11. Transient Thermal Response Curve



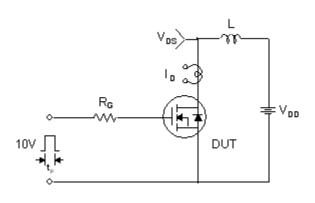
#### **Gate Charge Test Circuit & Waveform**

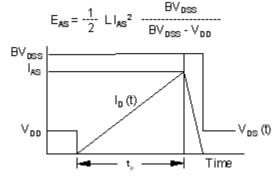


# **Resistive Switching Test Circuit & Waveforms**

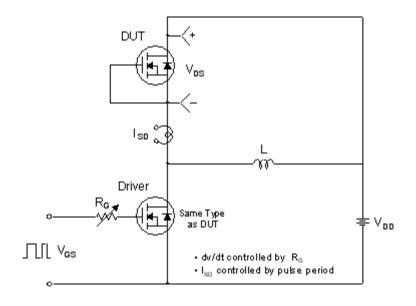


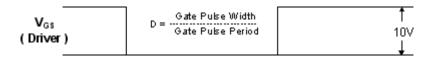
#### **Unclamped Inductive Switching Test Circuit & Waveforms**

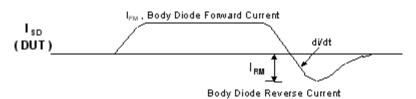


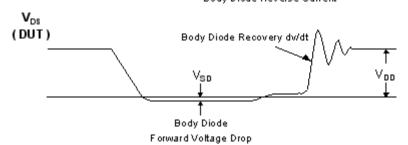


#### Peak Diode Recovery dv/dt Test Circuit & Waveforms



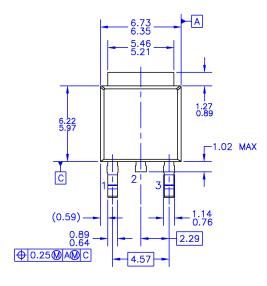


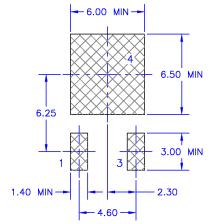




### **Mechanical Dimensions**

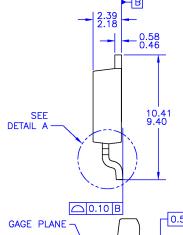
# **D-PAK**





4.32 MIN NOTE D 5.21 MIN



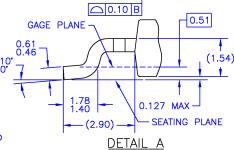


- NOTES: UNLESS OTHERWISE SPECIFIED

  A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.

  B) ALL DIMENSIONS ARE IN MILLIMETERS.
  C) DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-1994.
  D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.
  E) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.
  F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS.
  G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO220P1003X238-3N.
  H) DRAWING NUMBER AND REVISION: MKT-T0252A03REV8

  - DRAWING NUMBER AND REVISION: MKT-T0252A03REV8

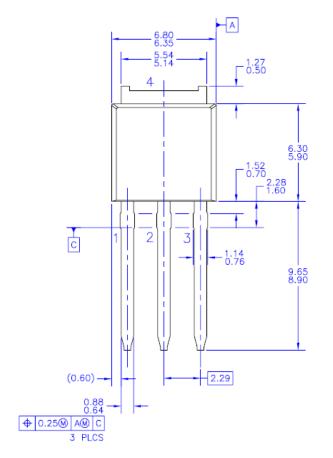


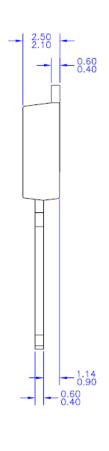
(ROTATED -90°) SCALE: 12X

Dimensions in Millimeters

# **Mechanical Dimensions**

# I-PAK







NOTES: UNLESS OTHERWISE SPECIFIED

- B)
- ALL DIMENSIONS ARE IN MILLIMETERS.
  THIS PACKAGE CONFORMS TO JEDEC, TO-251,
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**Dimensions in Millimeters** 





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